Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/579,499	MAKITA ET AL.	
Examiner	Art Unit	
Patrick J. Lee	2878	

	SEARCHED			
Çlass	Subclass	Date	Examiner	
250	206, 214R, 214D, 221, 222.1	10/9/2007	PL	
359	330	10/9/2007	PL	
359	341.3	10/9/2007	PL	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	10/9/2007	PL	
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